

# IRLBD59N04E

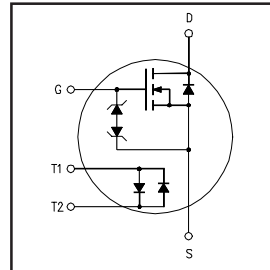
HEXFET® Power MOSFET

- Integrated Temperature Sensing Diode
- Ultra Low On-Resistance
- Dynamic dv/dt Rating
- 175°C Operating Temperature
- Fully Avalanche Rated
- Zener Gate Protected

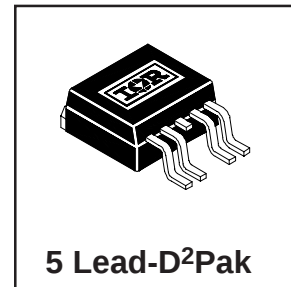
## Description

The IRLBD59N04E is a 40V, N-channel HEXFET® power MOSFET with gate protection provided by integrated back to back zener diodes. Temperature sensing is given by the change in forward voltage drop of two antiparallel electrically isolated poly-silicon diodes.

The IRLBD59N04E provides cost effective temperature sensing for system protection along with the quality and ruggedness you expect from a HEXFET power MOSFET.



|                            |
|----------------------------|
| $V_{DSS} = 40V$            |
| $R_{DS(on)} = 0.018\Omega$ |
| $I_D = 59A\text{⑥}$        |



## Absolute Maximum Ratings

|                           | Parameter                                | Max.                   | Units |
|---------------------------|------------------------------------------|------------------------|-------|
| $I_D @ T_C = 25^\circ C$  | Continuous Drain Current, $V_{GS} @ 10V$ | 59⑥                    | A     |
| $I_D @ T_C = 100^\circ C$ | Continuous Drain Current, $V_{GS} @ 10V$ | 41                     |       |
| $I_{DM}$                  | Pulsed Drain Current ①                   | 230                    |       |
| $P_D @ T_C = 25^\circ C$  | Power Dissipation                        | 130                    | W     |
|                           | Linear Derating Factor                   | 0.89                   | W/°C  |
| $V_{GS}$                  | Gate-to-Source Voltage                   | $\pm 10$               | V     |
| $E_{AS}$                  | Single Pulse Avalanche Energy②           | 320                    | mJ    |
| $I_{AR}$                  | Avalanche Current①                       | 35                     | A     |
| $E_{AR}$                  | Repetitive Avalanche Energy①             | 13                     | mJ    |
| dv/dt                     | Peak Diode Recovery dv/dt ③              | 2.2                    | V/ns  |
| $I_G$                     | $V_{GS}$ Clamp Current                   | $\pm 50$               | mA    |
| $V_{ESD}$                 | Electrostatic Votage Rating⑦             | $\pm 2.0$              | kV    |
| $T_J$                     | Operating Junction and                   | -55 to + 175           | °C    |
| $T_{STG}$                 | Storage Temperature Range                |                        |       |
|                           | Soldering Temperature, for 10 seconds    | 300 (1.6mm from case ) |       |
|                           | Mounting torque, 6-32 or M3 screw        | 10 lbf•in (1.1N•m)     |       |

## Thermal Resistance

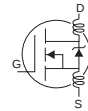
|                 | Parameter                                          | Typ. | Max. | Units |
|-----------------|----------------------------------------------------|------|------|-------|
| $R_{\theta JC}$ | Junction-to-Case                                   | —    | 1.12 | °C/W  |
| $R_{\theta JA}$ | Junction-to-Ambient ( PCB Mounted, steady-state)** | —    | 40   |       |

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International  
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## Electrical Characteristics @ $T_J = 25^\circ\text{C}$ (unless otherwise specified)

|                                 | Parameter                            | Min. | Typ.  | Max.  | Units               | Conditions                                                                  |
|---------------------------------|--------------------------------------|------|-------|-------|---------------------|-----------------------------------------------------------------------------|
| $V_{(BR)DSS}$                   | Drain-to-Source Breakdown Voltage    | 40   | —     | —     | V                   | $V_{GS} = 0V, I_D = 250\mu A$                                               |
| $\Delta V_{(BR)DSS}/\Delta T_J$ | Breakdown Voltage Temp. Coefficient  | —    | 0.036 | —     | V/ $^\circ\text{C}$ | Reference to $25^\circ\text{C}$ , $I_D = 1mA$                               |
| $R_{DS(on)}$                    | Static Drain-to-Source On-Resistance | —    | —     | 0.018 | $\Omega$            | $V_{GS} = 10V, I_D = 35A$ ④                                                 |
|                                 |                                      | —    | —     | 0.021 |                     | $V_{GS} = 5.0V, I_D = 30A$ ④                                                |
| $V_{GS(th)}$                    | Gate Threshold Voltage               | 1.0  | —     | 2.0   | V                   | $V_{DS} = V_{GS}, I_D = 250\mu A$                                           |
| $V_{GS}$                        | Clamp Voltage                        | 10   | —     | 20    | V                   | $I_{GSS} = 20\mu A$                                                         |
| $g_{fs}$                        | Forward Transconductance             | 29   | —     | —     | S                   | $V_{DS} = 25V, I_D = 35A$                                                   |
| $I_{DSS}$                       | Drain-to-Source Leakage Current      | —    | —     | 25    | $\mu A$             | $V_{DS} = 40V, V_{GS} = 0V$                                                 |
|                                 |                                      | —    | —     | 250   |                     | $V_{DS} = 32V, V_{GS} = 0V, T_J = 150^\circ\text{C}$                        |
| $I_{GSS}$                       | Gate-to-Source Forward Leakage       | —    | —     | 1.0   | $\mu A$             | $V_{GS} = 5.0V$                                                             |
|                                 | Gate-to-Source Reverse Leakage       | —    | —     | -1.0  |                     | $V_{GS} = -5.0V$                                                            |
| $Q_g$                           | Total Gate Charge                    | —    | —     | 53    | nC                  | $I_D = 35A$                                                                 |
| $Q_{gs}$                        | Gate-to-Source Charge                | —    | —     | 16    |                     | $V_{DS} = 32V$                                                              |
| $Q_{gd}$                        | Gate-to-Drain ("Miller") Charge      | —    | —     | 18    |                     | $V_{GS} = 5.0V$ , See Fig. 6 and 13 ④                                       |
| $t_{d(on)}$                     | Turn-On Delay Time                   | —    | 7.9   | —     | ns                  | $V_{DD} = 20V$                                                              |
| $t_r$                           | Rise Time                            | —    | 110   | —     |                     | $I_D = 35A$                                                                 |
| $t_{d(off)}$                    | Turn-Off Delay Time                  | —    | 30    | —     |                     | $R_G = 5.1\Omega$ ,                                                         |
| $t_f$                           | Fall Time                            | —    | 74    | —     |                     | $V_{GS} = 5.0V$ , See Fig.10 ④                                              |
| $L_D$                           | Internal Drain Inductance            | —    | 2.0   | —     | nH                  | Between lead,<br>6mm (0.25in.)<br>from package<br>and center of die contact |
| $L_S$                           | Internal Source Inductance           | —    | 5.0   | —     |                     |                                                                             |
| $C_{iss}$                       | Input Capacitance                    | —    | 2310  | —     | pF                  | $V_{GS} = 0V$                                                               |
| $C_{oss}$                       | Output Capacitance                   | —    | 640   | —     |                     | $V_{DS} = 25V$                                                              |
| $C_{rss}$                       | Reverse Transfer Capacitance         | —    | 130   | —     |                     | $f = 1.0MHz$ , See Fig. 5                                                   |
| $C_{oss}$                       | Output Capacitance                   | —    | 2250  | —     |                     | $V_{GS} = 0V, V_{DS} = 1.0V, f = 1.0MHz$                                    |
| $C_{oss}$                       | Output Capacitance                   | —    | 580   | —     |                     | $V_{GS} = 0V, V_{DS} = 32V, f = 1.0MHz$                                     |
| $C_{oss \text{ eff.}}$          | Effective Output Capacitance ⑤       | —    | 530   | —     |                     | $V_{GS} = 0V, V_{DS} = 0V \text{ to } 32V$                                  |

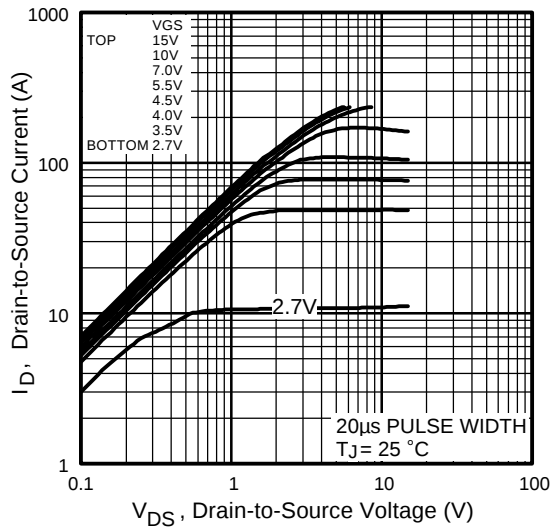


## Source-Drain Ratings and Characteristics

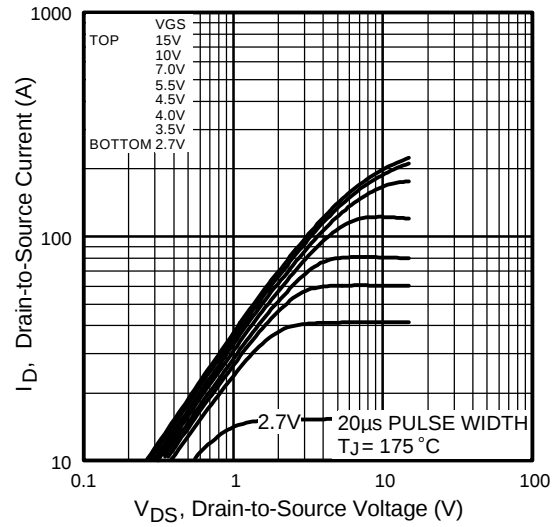
|          | Parameter                              | Min.                                                                        | Typ. | Max. | Units | Conditions                                                     |
|----------|----------------------------------------|-----------------------------------------------------------------------------|------|------|-------|----------------------------------------------------------------|
| $I_S$    | Continuous Source Current (Body Diode) | —                                                                           | —    | 59   | A     | MOSFET symbol showing the integral reverse p-n junction diode. |
| $I_{SM}$ | Pulsed Source Current (Body Diode) ①   | —                                                                           | —    | 230  |       |                                                                |
| $V_{SD}$ | Diode Forward Voltage                  | —                                                                           | —    | 1.3  | V     | $T_J = 25^\circ\text{C}, I_S = 35A, V_{GS} = 0V$ ④             |
| $t_{rr}$ | Reverse Recovery Time                  | —                                                                           | 54   | 81   | ns    | $T_J = 25^\circ\text{C}, I_F = 35A$                            |
| $Q_{rr}$ | Reverse Recovery Charge                | —                                                                           | 90   | 130  | nC    | $di/dt = 100A/\mu s$ ④                                         |
| $t_{on}$ | Forward Turn-On Time                   | Intrinsic turn-on time is negligible (turn-on is dominated by $L_S + L_D$ ) |      |      |       |                                                                |

## Sense Diode Rating

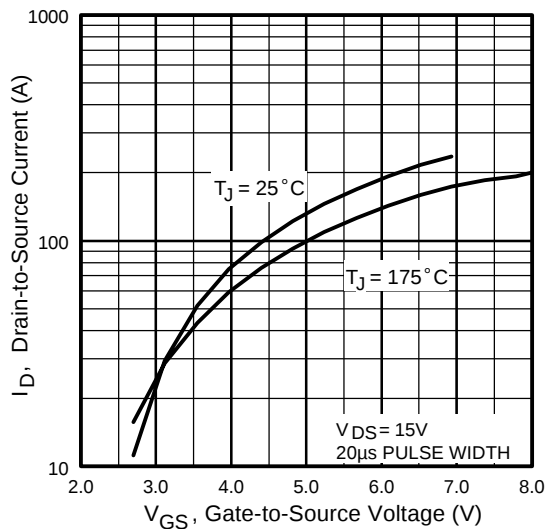
|                         | Parameter                           | Min.  | Typ.  | Max.  | Units                | Conditions                    |
|-------------------------|-------------------------------------|-------|-------|-------|----------------------|-------------------------------|
| $V_{FM}$                | Sense Diode Maximum Voltage Drop    | 675   | —     | 725   | mV                   | $I_F = 250\mu A$              |
| $\Delta V_F/\Delta T_J$ | Sense Diode Temperature Coefficient | -1.30 | -1.40 | -1.58 | mV/ $^\circ\text{C}$ | $I_F = 250\mu A$ , See Fig.14 |



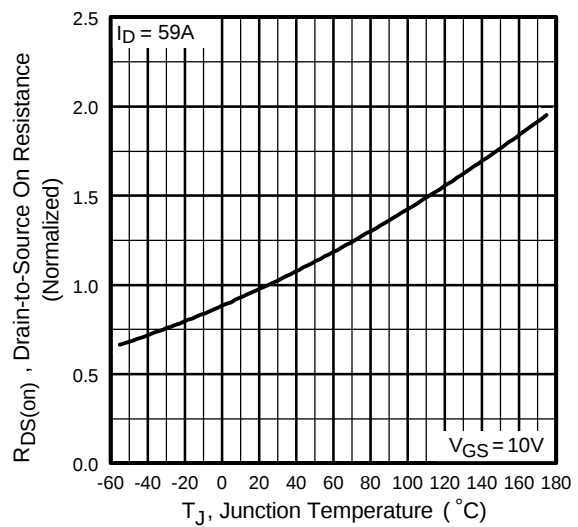
**Fig 1.** Typical Output Characteristics



**Fig 2.** Typical Output Characteristics



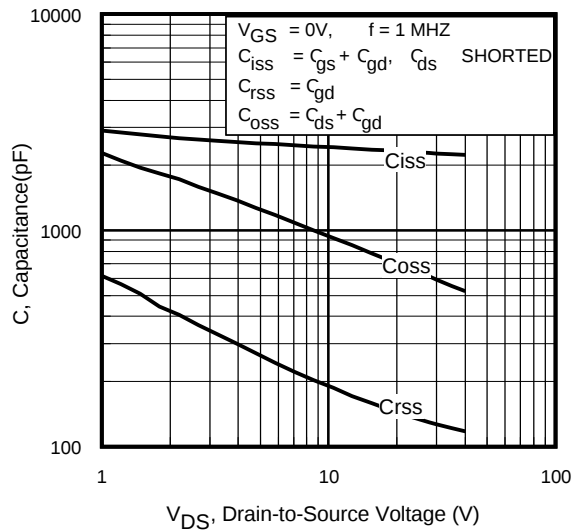
**Fig 3.** Typical Transfer Characteristics



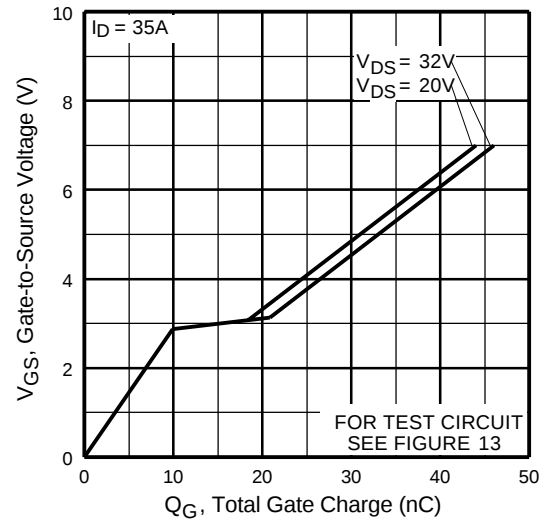
**Fig 4.** Normalized On-Resistance Vs. Temperature

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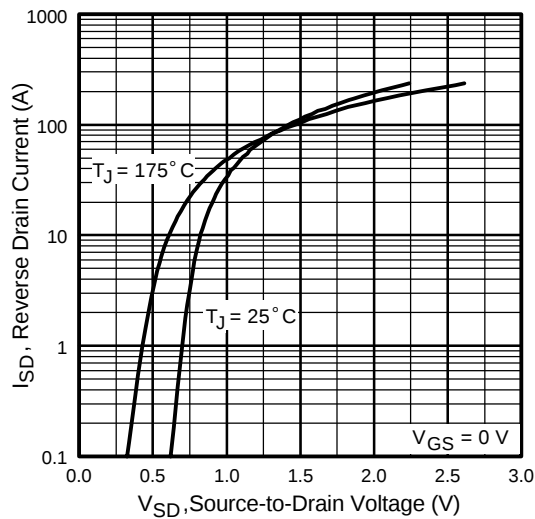
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**IR** Rectifier



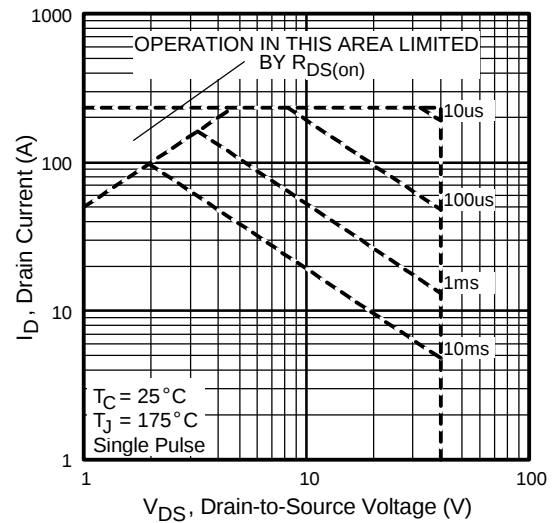
**Fig 5.** Typical Capacitance Vs. Drain-to-Source Voltage



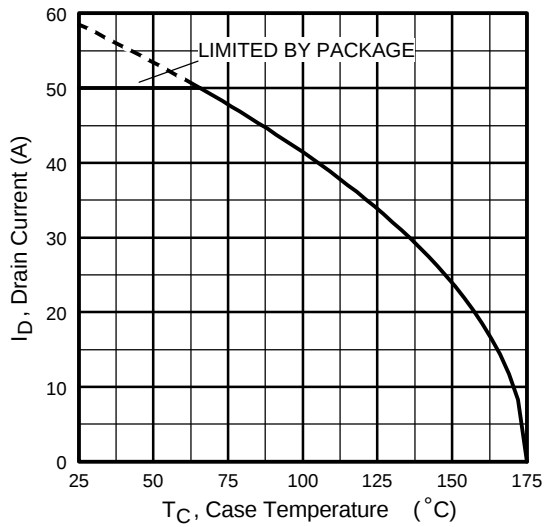
**Fig 6.** Typical Gate Charge Vs. Gate-to-Source Voltage



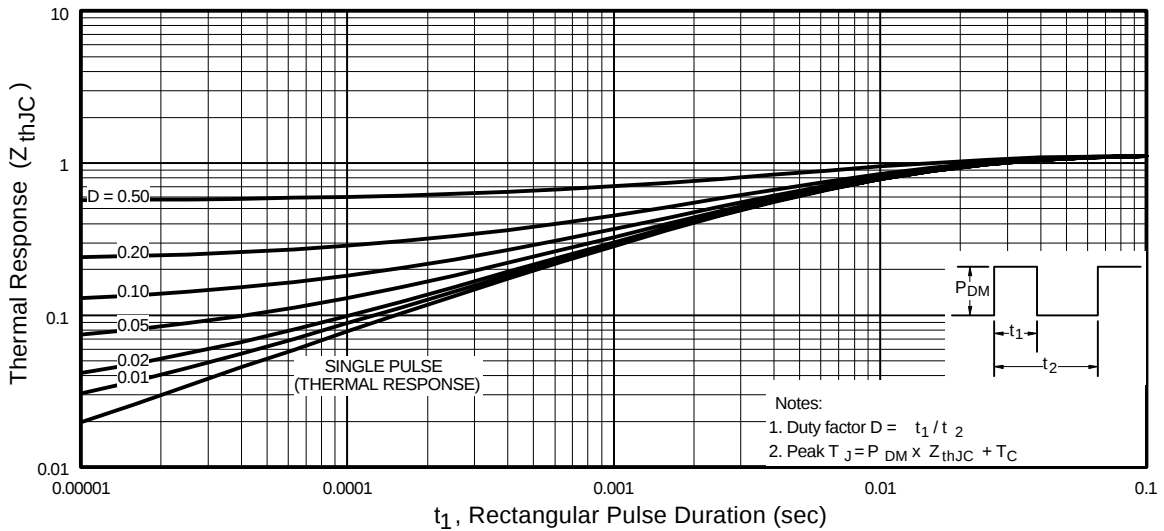
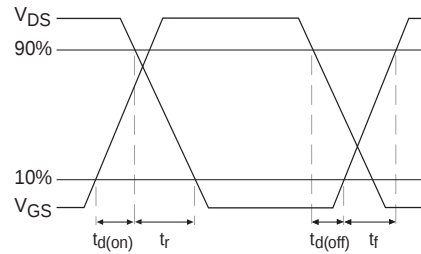
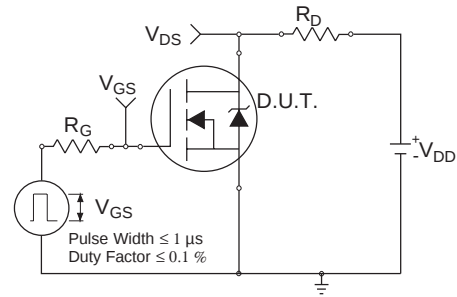
**Fig 7.** Typical Source-Drain Diode Forward Voltage



**Fig 8.** Maximum Safe Operating Area



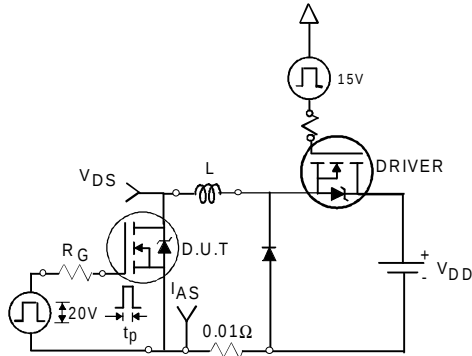
**Fig 9.** Maximum Drain Current Vs. Case Temperature



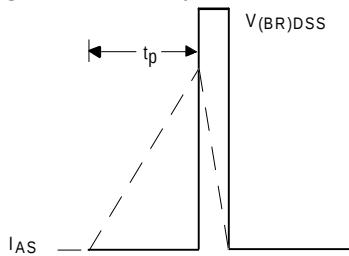
**Fig 11.** Maximum Effective Transient Thermal Impedance, Junction-to-Case

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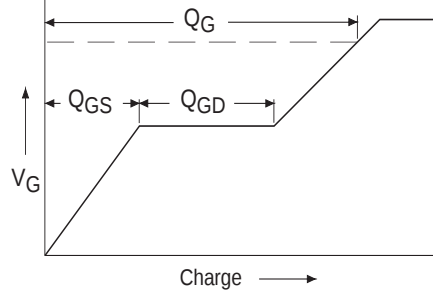
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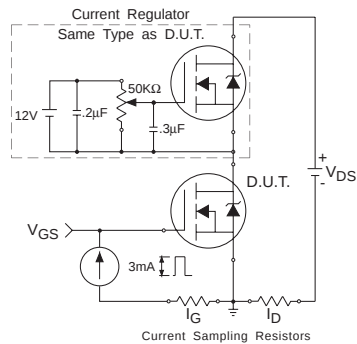
**Fig 12a.** Unclamped Inductive Test Circuit



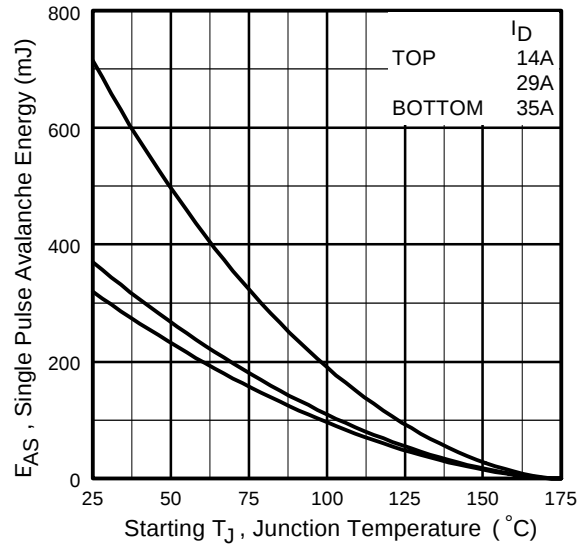
**Fig 12b.** Unclamped Inductive Waveforms



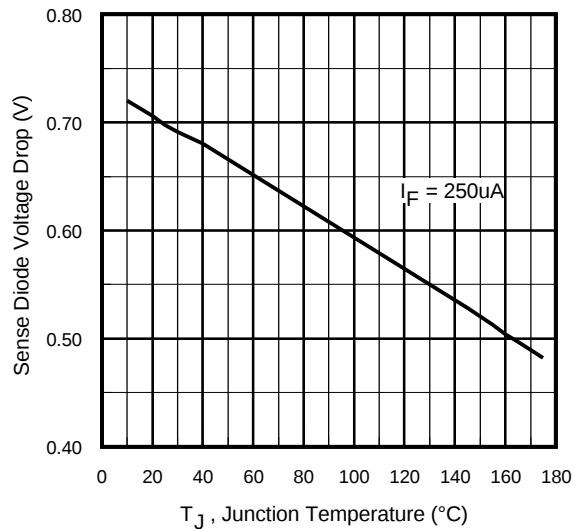
**Fig 13a.** Basic Gate Charge Waveform



**Fig 13b.** Gate Charge Test Circuit

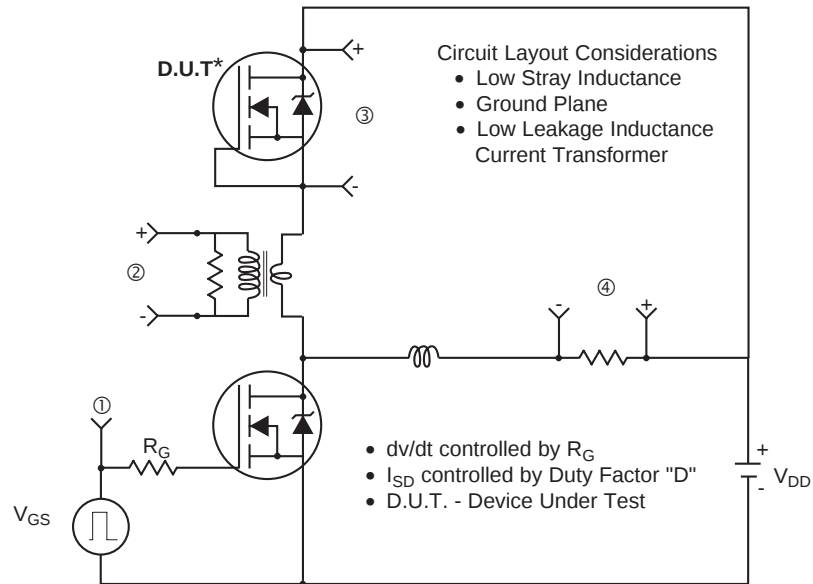


**Fig 12c.** Maximum Avalanche Energy Vs. Drain Current

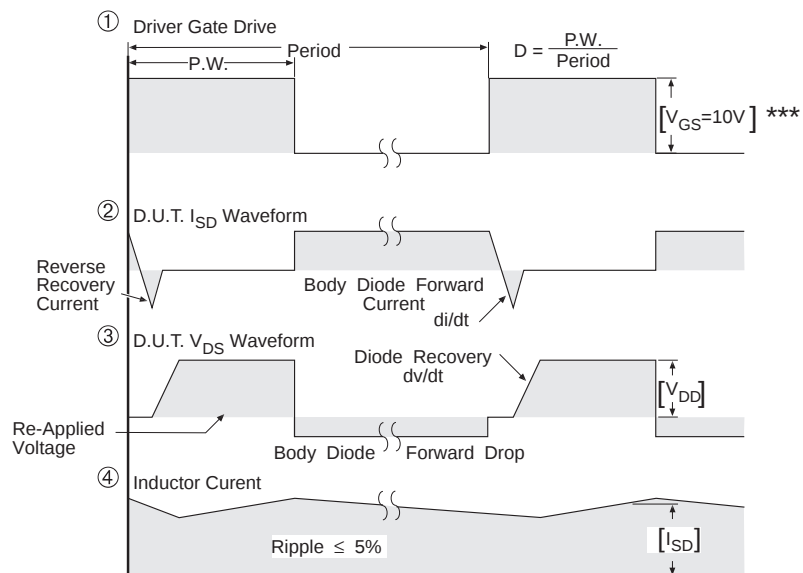


**Fig 14.** Sense Diode Voltage Drop Vs. Temperature

### Peak Diode Recovery dv/dt Test Circuit



\* Reverse Polarity of D.U.T for P-Channel



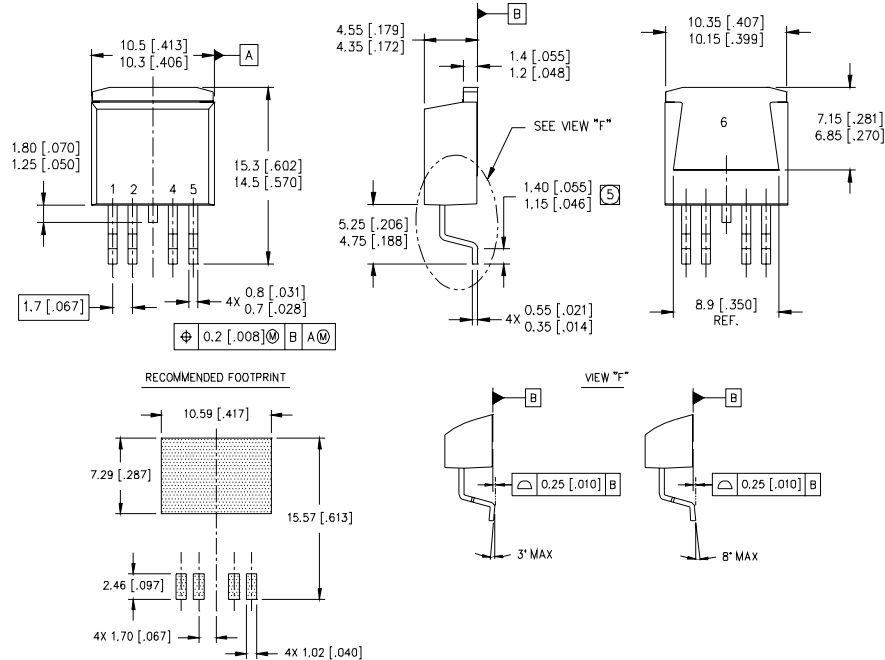
\*\*\*  $V_{GS} = 5.0V$  for Logic Level and 3V Drive Devices

**Fig 15.** For N-channel HEXFET® power MOSFETs

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## Case Outline 5 Lead-D<sup>2</sup>Pak (SMD-220)



### NOTES:

1. DIMENSIONING & TOLERANCING PER ASME Y14.5M-1994.
2. CONTROLLING DIMENSION: MILLIMETER.
3. DIMENSIONS ARE SHOWN IN MILLIMETERS [INCHES].
4. OUTLINE SIMILAR TO JEDEC OUTLINE SERIES TO-263.
- ⑤ DIMENSION IS THE LENGTH OF LEAD FOR SOLDERING TO A SUBSTRATE.

### PIN ASSIGNMENTS

- 1 - G - GATE
- 2 - T1 - ANODE
- 3 - D - DRAIN
- 4 - T2 - CATHODE
- 5 - S - SOURCE

### Notes:

- ① Repetitive rating; pulse width limited by max. junction temperature. ( See fig. 11 )
- ② Starting  $T_J = 25^\circ\text{C}$ ,  $L = 0.52\text{mH}$   
 $R_G = 25\Omega$ ,  $I_{AS} = 35\text{A}$ . (See Figure 12)
- ③  $I_{SD} \leq 35\text{A}$ ,  $di/dt \leq 160\text{A}/\mu\text{s}$ ,  $V_{DD} \leq V_{(BR)DSS}$ ,  
 $T_J \leq 175^\circ\text{C}$
- ④ Pulse width  $\leq 300\mu\text{s}$ ; duty cycle  $\leq 2\%$ .

- ⑤  $C_{OSS}$  eff. is a fixed capacitance that gives the same charging time as  $C_{OSS}$  while  $V_{DS}$  is rising from 0 to 80%  $V_{DSS}$
- ⑥ Current limited by the package ( Die current is 59A)
- ⑦  $C = 100\text{pF}$ ,  $R = 1.5\text{k}\Omega$

\*\* When mounted on 1" square PCB ( FR-4 or G-10 Material ).  
For recommended soldering techniques refer to application note #AN-994.

International  
**IR** Rectifier

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**IR EUROPEAN REGIONAL CENTRE:** 439/445 Godstone Rd, Whyteleafe, Surrey CR3 0BL, UK Tel: ++ 44 (0)20 8645 8000  
**IR CANADA:** 15 Lincoln Court, Brampton, Ontario L6T3Z2, Tel: (905) 453 2200  
**IR GERMANY:** Saalburgstrasse 157, 61350 Bad Homburg Tel: ++ 49 (0) 6172 96590  
**IR ITALY:** Via Liguria 49, 10071 Borgaro, Torino Tel: ++ 39 011 451 0111  
**IR JAPAN:** K&H Bldg., 2F, 30-4 Nishi-Ikebukuro 3-Chome, Toshima-Ku, Tokyo 171 Tel: 81 (0)3 3983 0086  
**IR SOUTHEAST ASIA:** 1 Kim Seng Promenade, Great World City West Tower, 13-11, Singapore 237994 Tel: ++ 65 (0)838 4630  
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*Data and specifications subject to change without notice. 4/00*